BAYESIAN INFERENCE FOR A SOFTWARE RELIABILITY MODEL USING METRICS INFORMATION

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ABSTRACT

We wish to predict the number of faults N and the time to next failure of a piece of software. Software metrics data are used to estimate the prior distribution of N via a Poisson regression model. Given failure time data, and a well known model for software failures, we show how to sample the posterior distribution using Gibbs sampling, via the package "WinBugs". The approach is illustrated with an example.

1. INTRODUCTION

Software reliability can be defined as "the probability of failure-free operation of a computer code for a specified mission time in a specified input environment", [1]. The majority of software reliability models are concerned with the prediction of interfailure times, say $T_1, T_2, \ldots$, see for example [2] or [3]. It would seem plausible that failure times are related to the number of faults (or bugs) in the software, say N, and various models have been developed which are based on a bug counting approach. Specific examples are the models of [4], [5], [6] and [7]. See [1] for a general review and comments about alternative approaches to failure time prediction.

A second method for reliability assessment, which we do not consider in this article, uses random or partition testing methods to estimate the failure rate or probability that an input to the program from the operational profile will produce an erroneous output. See, for example, [8].

A third approach to assessing software reliability, particularly in the software development process, concentrates on the measurement of characteristics of a piece of software, called software metrics. The most well known software metrics are probably the simple lines of code (LOC) and McCabe's cyclomatic complexity measure [9][1]. A great many other metrics have also been defined. See [10] for a review.

[1] This measure is based on the representation of the code as a directed graph and is equal to be the number of edges minus the number of nodes plus 2.

Various models have been used in order to predict the number of bugs (or other measures of quality such as cost, amendements etc.) in a piece of software using software metrics data. For example, [11], [12] etc. used (classical) logistic regression approaches, normal regression models have also been used, see [13] and [14] introduced a neural net approach.

In this paper we are concerned with prediction of the number of bugs in a piece of software and the time to next failure given both failure time information and metrics data. Our objective is to introduce Bayesian inference techniques in order to combine the two sources of information.

In Section 2, we introduce on of the most well known software reliability models and comment on Bayesian inference for this model. In Section 3, we introduce a Bayesian logistic regression model for the number number of faults in a piece of software and combine this model with that of the previous section and illustrate how to carry out Bayesian inference using Gibbs sampling. In Section 4, we illustrate our approach with an example using real metrics data and in Section 5 we consider some extensions.

2. A SIMPLE MODEL FOR SOFTWARE FAILURES

The Jelinski Moranda model for software reliability [4] is one of the simplest. It supposes that the distribution of the j'th interfailure time is given by

$$T_j|N,\phi \sim \mathcal{E}\left((N-j+1)\phi\right),$$

an exponential distribution with mean $1/(N-j+1)\phi$.

The underlying (possibly unrealistic) assumptions of this model are:

1. The program contains an initial number of faults N.
2. Each bug contributes the same amount to the failure rate.
3. After each observed failure, a bug is detected and corrected.

Bayesian inference for the Jelinski Moranda model is considered in, for example, [15] where the following natural independent prior distributions for N and ϕ are introduced:

$$\begin{aligned} N &\sim \mathcal{P}(\lambda) \qquad \text{a Poisson distribution} \\ \phi &\sim \mathcal{G}(\alpha,\nu) \qquad \text{a gamma density} \end{aligned}$$

Given the observation of n failures, then the likelihood function is, for $N \geq n$,

$$l(N,\phi|\text{data}) \propto \frac{N!}{(N-n)!}\phi^n \exp\left(-\sum_{j=1}^{n}(N-j+1)t_j\phi\right)$$

so that, for example, the full conditional posterior distributions are easily evaluated:

$$\begin{aligned} N-n|\text{data},\phi &\sim \mathcal{P}\left(\lambda\exp(-n\bar{t}\phi)\right) \qquad \text{where } \bar{t}=\tfrac{1}{n}\textstyle\sum_{j=1}^{n} t_j \\ \phi|\text{data},N &\sim \mathcal{G}\left(\alpha+n,\nu+\sum_{j=1}^{n}(N-j+1)t_j\right). \end{aligned}$$

Thus, it is easy to set up a Gibbs sampling scheme to sample the posterior distribution of (N,ϕ)[2]

One problem with this model is sensitivity to the choice of prior distribution, see, e.g [16], [17]. In particular, it is unclear how to elect the prior parameters λ,α,ν. Given little prior knowledge, it would be natural to elect an uninformative, improper, prior distribution for (N,ϕ) but it is easy to show that in this case, the posterior distribution is also improper, see [17].

In the following section, we illustrate how software metrics data might be used to provide information about the prior distribution for N.

3. SOFTWARE METRICS

In this section, we consider first a different problem, that of predicting the number of faults in a software program given metrics data.

Suppose that, for a collection of programs m, we calculate k software metrics $\mathbf{X}_i=(X_{i1},\ldots,X_{ik})$, where $i=1,\ldots,m$.

Let N_i be the number of faults in program i. Then the following logistic regression is a natural model relating faults to software metrics:

$$\begin{aligned} N_i|\lambda_i &\sim \mathcal{P}(\lambda_i) \qquad \text{as in the previous section} \\ \log\lambda_i &= \beta_0+X_{i1}\beta_1+\ldots+X_{ik}\beta_k \end{aligned}$$

Given fault data $N_1=n_1,\ldots,N_m=n_m$, various authors have used classical logistic regression to estimate the unknown parameters $\boldsymbol{\beta}$, see e.g. [12], [13]. In this case we consider a Bayesian approach, which, as far as we know, has not been considered previously for metrics data.

Given a prior distribution for $\boldsymbol{\beta}$, for example a normal distribution $\boldsymbol{\beta}\sim\mathcal{N}(\mathbf{b},\mathbf{B})$ then it can be shown that all of the conditional posterior parameter distributions are log concave and so the adaptive rejection algorithm [18] can be used to sample from the posterior distribution. This scheme is preprogrammed into the Gibbs sampling package "WinBugs" [19].

[2]The marginal posteriors of N and ϕ can also be derived up to truncation of a one dimensional summation.

One problem with metrics data is that typically, software metrics are very highly correlated with program size, see e.g. [12]. Thus, rather than use the raw metrics data, to avoid problems of colinearity, it is normal to transform the metrics using, for example, principal components. Typically, we will have little prior information concerning these components and thus it is normal to use a relatively diffuse prior distribution for $\boldsymbol{\beta}$.

Assuming that both sources of information are available, the logistic regression model for metrics data can be combined with the Jelinski Moranda model for failure times. Figure 1 shows a directed graph (a "Doodle" in Winbugs) which illustrates the dependence structure of the combined model. (In the diagram, we have used Nnew instead of N for the number of bugs we are trying to predict.) Using the graph, distributional assumptions for each node can be specified within Winbugs.

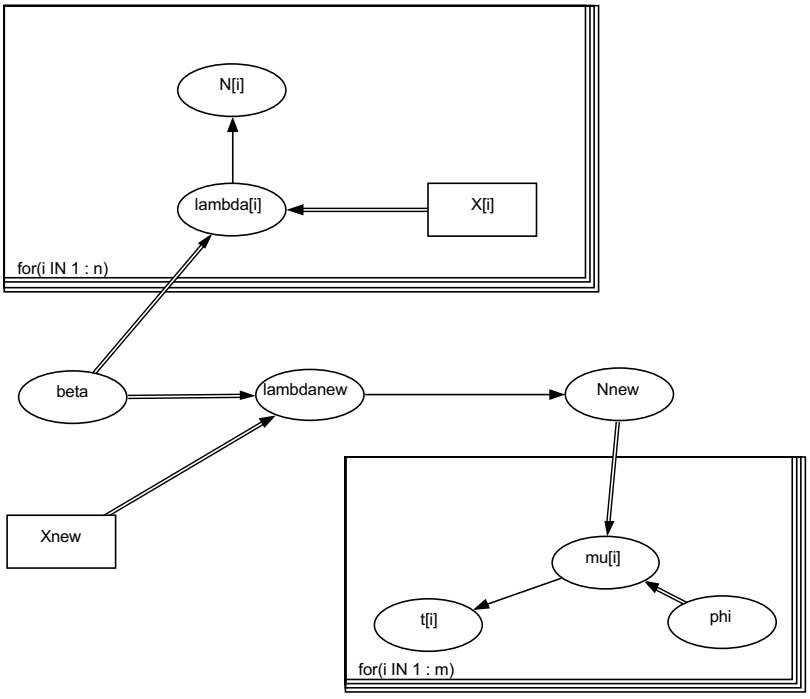

Figure 1: Doodle of Model Structure.

We illustrate the approach with an example using real metrics data and simulated failure time data in the following section.

4. EXAMPLE

Ten metrics (Basili Hutchens, depth of nesting, LOC, McCabe, YAM etc.) and the number of amendments were collected from 36 unstructured software

programs. A simple correlations analysis showed that the metrics were very highly correlated and thus, a principal components analysis was undertaken, which showed that virtually all (99%) of the variance in the metrics data was explained by the first five principal components.

Here we use amendments to represent faults and assume the logistic regression model of section 3 for the mean number of amendments where the vector $\mathbf{X}$ contains the first five principal components and $\boldsymbol{\beta} = (\beta_0, ..., \beta_5)$. Independent, relatively uninformative, normal distributions with mean 0 and precision 10^{-5} were chosen for each β_i.

5 interfailure times were also generated using the Jelinski Moranda model (with $\phi = 0.1$) from a program containing 9 amendments / bugs.

A relatively uninformative gamma prior distribution $\mathcal{G}(.001, .001)$ was used for ϕ. A Gibbs run of 5000 iterations to "burn in" the chain and 25000 iterations in equilibrium was used. (Using the usual checks, the chain could be seen to have coverged before 5000 iterations).

In this case, the posterior mean estimate for $\boldsymbol{\beta}$ coincides almost exactly with the classical logistic regression estimate based on the 36 metric data, which we would expect given the use of noninformative prior distributions. In Figures 2 and 3, we illustrate the estimated posterior densities for N (Nnew) and ϕ.

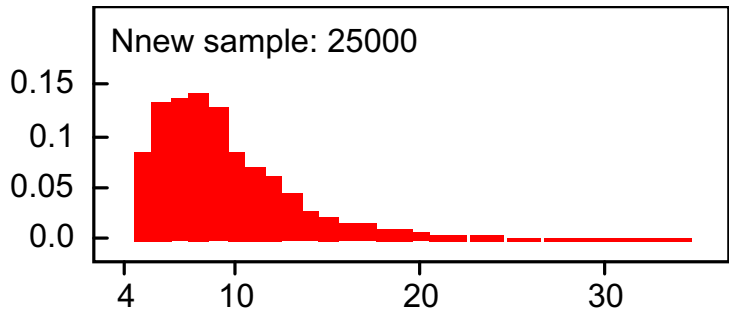

Figure 2: Posterior density of N.

Values of N between 6 and 9 have posterior probabilities greater than 0.1. The posterior mean is $E[N|\text{data}] \simeq 9.4$ (standard deviation 3.7) and a 95% probability interval for N is [5,19]. Thus, the true value of N has been well estimated given the metrics and failure data.

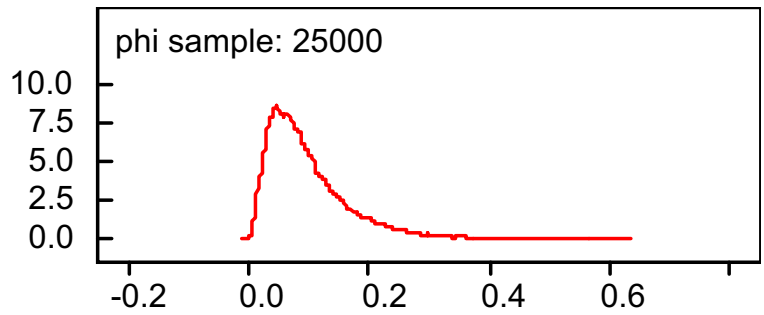

Figure 3: Posterior density of ϕ.

The posterior mean of ϕ is $E[\phi|\text{data}] \simeq 0.102$ (standard deviation 0.072) which again coincides very well with the true generating value.

Finally, Figure 4 illustrates the reliability function for the time to next (sixth) failure of the program: $P(T_6 > t|\text{datos})$. It can be seen that there is a positive probability that the program will not fail again, which is equal to the posterior probability that the program contained only the five discovered faults.

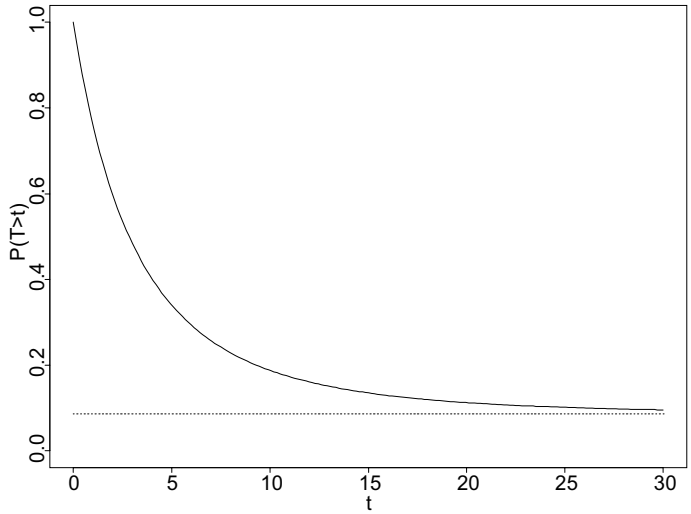

Figure 4: Reliability function for the time to next failure.

5. CONCLUSIONS AND EXTENSIONS

In this paper we have shown how Bayesian inference concerning the number of bugs and the time to next failure of a piece of software can be carried out given both failure time and software metrics data. Here we have supposed the Jelinski Moranda model for failure times, but the same basic techniques

may be applied to other models. Work is currently in progress on Bayesian inference for these models.

When there are a selection of possible models, the problem of model choice becomes important. Theoretically, different models may be assessed from a Bayesian perspective via the use of Bayes factors, see e.g. [20]. A practical problem is that Bayes factors are difficult to calculate solely from the WinBugs output and thus, the programming task is more complicated.

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